

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/588,145	LI, JIAN	
Examiner		Art Unit SHAWNTINA FUQUA		3742
				Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,852,953	02-2005	Lee, Wen-Ching	219/393
	B US-			
	C US-			
	D US-			
	E US-			
	F US-			
	G US-			
	H US-			
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	J US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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